

**Search Notes****Application/Control No.**

09/815,446

**Examiner**

Dwin M. Craig

**Applicant(s)/Patent under Reexamination**

BODE ET AL.

**Art Unit**

2123

**SEARCHED**

Class	Subclass	Date	Examiner
703	6	7/5/2006	DML
430	30	7/5/2006	DML
UPDATED			
700	121	6/29/2006	DML
438	5,7	6/28/2006	DML
356	508,509	6/28/2006	DML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US-PGPUBS, see interference search notes		7/5/2006	DML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) see search notes for the exact search strings)	6/27/2006	DML
GOOGLE (wafer mean error)	6/27/2006	DML
NIST Webspace (wafer mean error)	6/28/2006	DML
PALM (inventor name search)	7/5/2006	DML